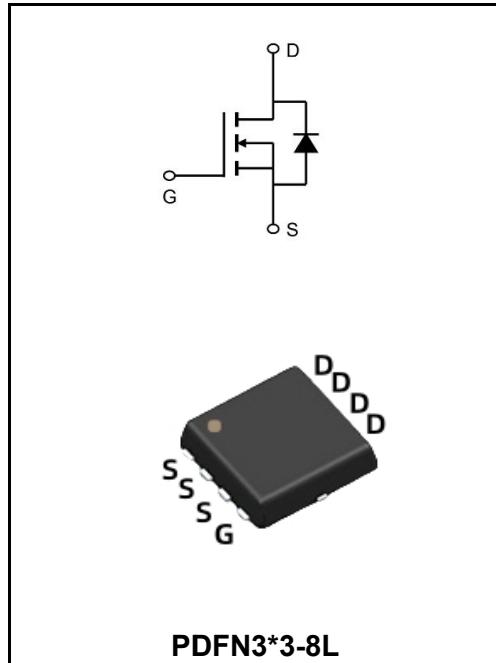


**40V N-CHANNEL ENHANCEMENT MODE MOSFET**
**MAIN CHARACTERISTICS**

$I_D$	50A
$V_{DSS}$	40V
$R_{DS(ON)}\text{-typ}(@V_{GS}=10V)$	<10 mΩ (Typ:7.5 mΩ)
$R_{DS(ON)}\text{-typ}(@V_{GS}=4.5V)$	<16 mΩ (Typ:11 mΩ)


**Description**

The YFW50N04DF uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

**Application**

- ◆ Battery protection
- ◆ Load switch
- ◆ Uninterruptible power supply

**Absolute Maximum Ratings ( $T_c=25^\circ C$  unless otherwise noted)**

Characteristics		Symbols	Value	Units
Drain-Source Voltage		$V_{DS}$	40	V
Gate - Source Voltage		$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup>	@ $T_c=25^\circ C$	$I_D$	50	A
Continuous Drain Current <sup>1</sup>	@ $T_c=100^\circ C$	$I_D$	28	A
Pulsed Drain Current <sup>2</sup>		$I_{DM}$	180	A
Single Pulse Avalanche Energy <sup>3</sup>		$E_{AS}$	81	mJ
Avalanche Current		$I_{AS}$	10	A
Total PowerDissipation <sup>4</sup>	$T_c=25^\circ C$	$P_D$	27.8	W
Storage Temperature Range		$T_{STG}$	-55 to +150	°C
Operating Junction Temperature Range		$T_J$	-55 to +150	°C
Thermal Resistance, Junction to Ambient <sup>1</sup>		$R_{\theta JA}$	60	°C/W
Thermal Resistance Junction-Case <sup>1</sup>		$R_{\theta JC}$	4.5	°C/W

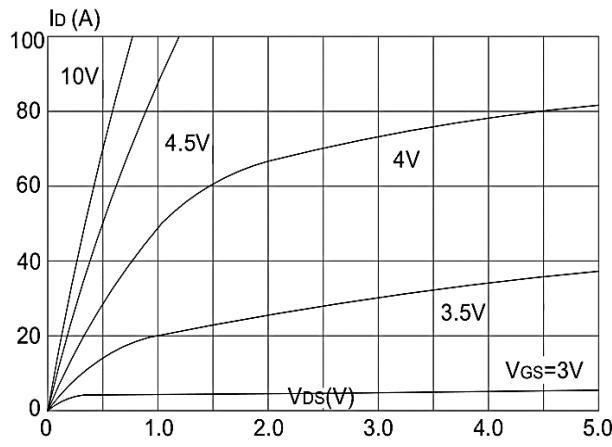
**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Parameter	Conditions	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu\text{A}$	$BV_{DSS}$	40	---	---	<b>V</b>
BVDSS Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$	$\Delta BV_{DSS}/\Delta T_J$	---	0.028	---	$\text{V}/^\circ\text{C}$
Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=30\text{A}$	$R_{DS(ON)}$	---	7.5	10	$\text{m}\Omega$
	$V_{GS}=4.5V, I_D=15\text{A}$		---	11	16	
Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D = 250\mu\text{A}$	$V_{GS(\text{th})}$	1.0	1.9	2.5	<b>V</b>
$V_{GS(\text{th})}$ Temperature Coefficient		$\Delta V_{GS(\text{th})}$	---	-6.16	---	$\text{mV}/^\circ\text{C}$
Drain-Source Leakage Current	$V_{DS}=40V, V_{GS}=0V, T_J=25^\circ\text{C}$	$I_{DSS}$	---	---	1	$\text{uA}$
	$V_{DS}=40V, V_{GS}=0V, T_J=55^\circ\text{C}$		---	---	5	
Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	$I_{GSS}$	---	---	$\pm 100$	<b>nA</b>
Forward Transconductance	$V_{DS}=5V, I_D=30\text{A}$	$g_{fs}$	---	22	---	<b>S</b>
Gate Resistance	$V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$	$R_g$	---	1.7	3.4	<b><math>\Omega</math></b>
Total Gate Charge (4.5V)	$V_{DS}=20V, V_{GS}=10V, I_D=25\text{A}$	$Q_g$	---	37	---	<b>nC</b>
Gate-Source Charge		$Q_{gs}$	---	6	---	
Gate-Drain Charge		$Q_{gd}$	---	7	---	
Turn-On Delay Time	$V_{DD}=30V, V_{GS}=10V, R_G=1\Omega, I_D=25\text{A}$	$t_{d(on)}$	---	12	---	<b>ns</b>
Rise Time		$T_r$	---	12	---	
Turn-Off Delay Time		$t_{d(OFF)}$	---	38	---	
Fall Time		$t_f$	---	9	---	
Input Capacitance	$V_{DS}=20V, V_{GS}=0V, f=1\text{MHz}$	$C_{iss}$	---	2400	---	<b>pF</b>
Output Capacitance		$C_{oss}$	---	192	---	
Reverse Transfer Capacitance		$C_{rss}$	---	165	---	
Continuous Source Current <sup>1,5</sup>	$V_G=V_D=0V$ , Force Current	$I_s$	---	---	50	<b>A</b>
Pulsed Source Current <sup>2,5</sup>		$I_{SM}$	---	---	180	<b>A</b>
Diode Forward Voltage <sup>2</sup>	$V_{GS}=0V, I_S=1\text{A}, T_J=25^\circ\text{C}$	$V_{SD}$	---	---	1.2	<b>V</b>
Reverse Recovery Time	$IF=30\text{A}, dl/dt=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$	$t_{rr}$	---	22	---	<b>nS</b>
Reverse Recovery Charge		$Q_{rr}$	---	11	---	<b>nC</b>

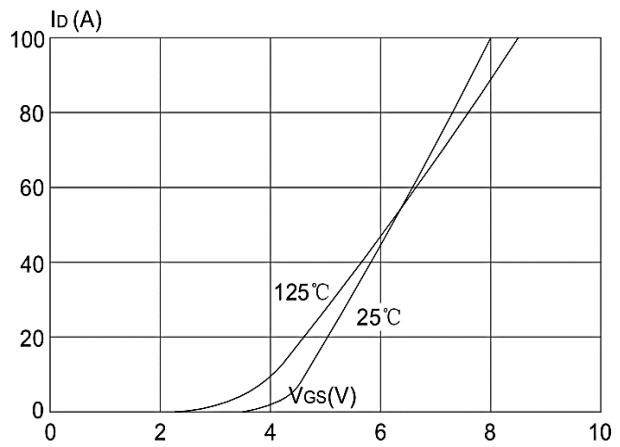
**Note :**

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3、The EAS data shows Max. rating . The test condition is  $V_{DD}=36V, V_{GS} =10V, L=0.1\text{mH}, IAS =10\text{A}$
- 4、The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation

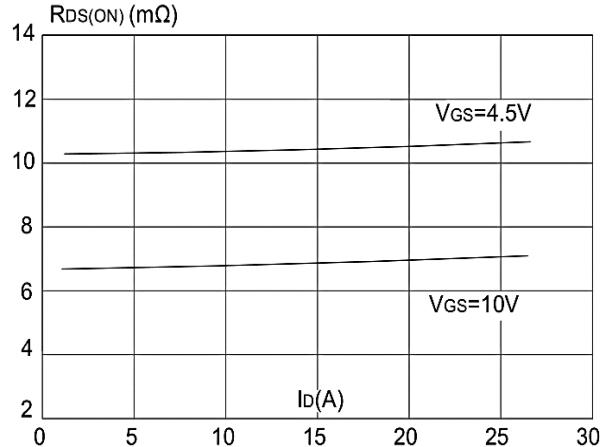
**Typical Characteristics**



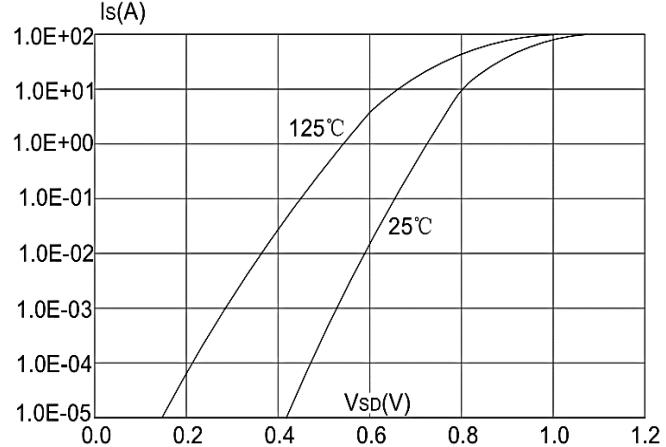
**Figure 1: Output Characteristics**



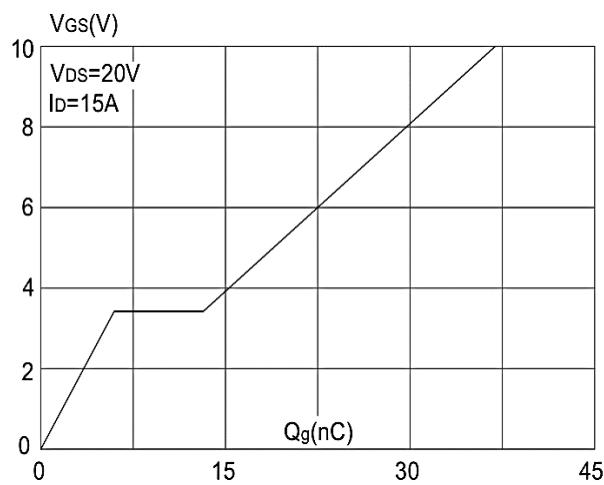
**Figure 2: Typical Transfer Characteristics**



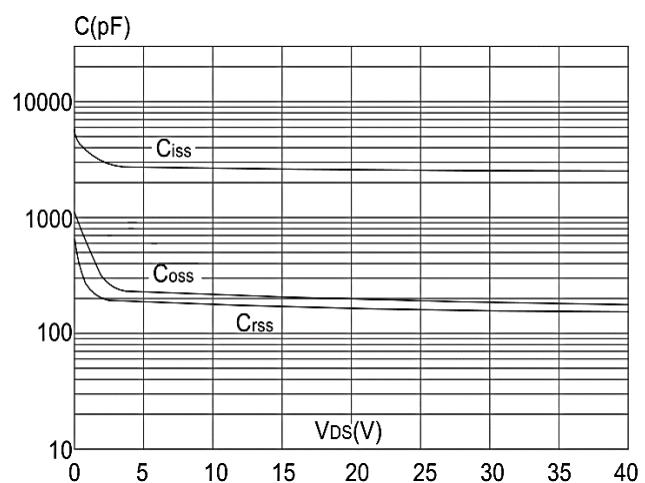
**Figure 3:On-resistance vs. Drain Current**



**Figure 4: Body Diode Characteristics**

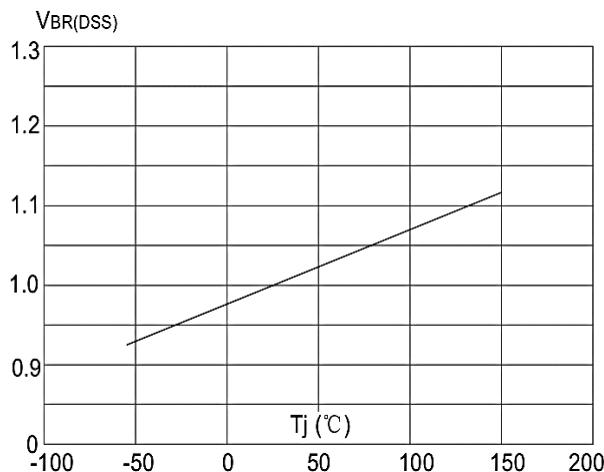


**Figure 5: Gate Charge Characteristics**

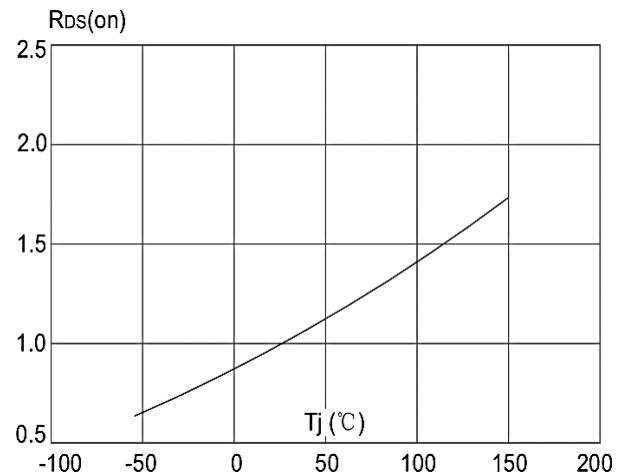


**Figure 6: Capacitance Characteristics**

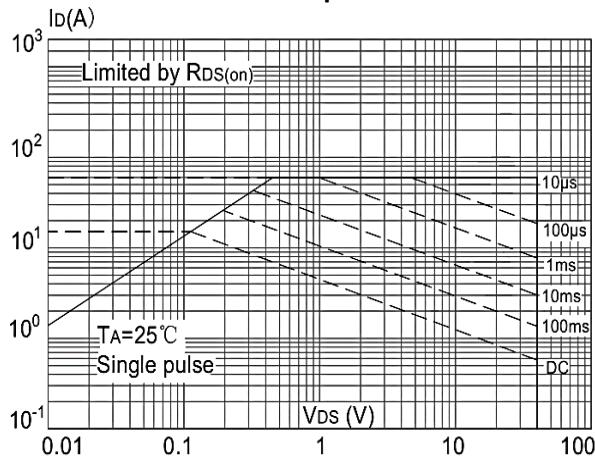
### Typical Characteristics



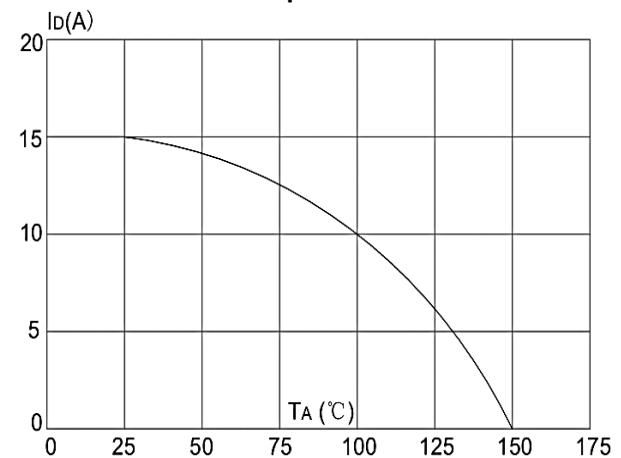
**Figure 7: Normalized Breakdown Voltage vs. Junction Temperature**



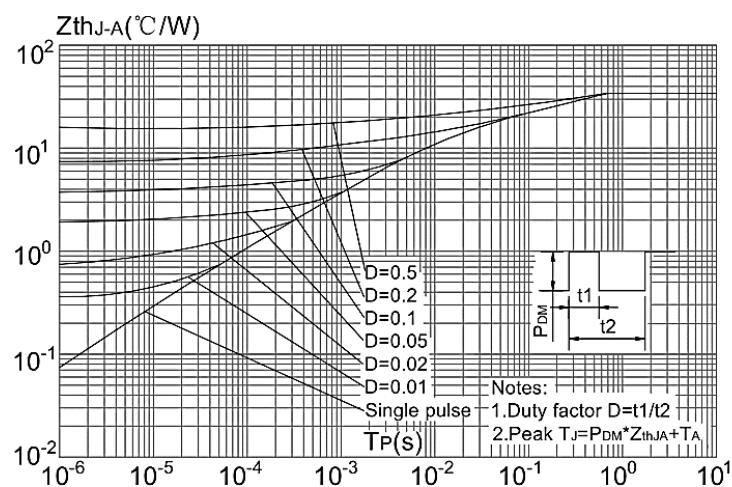
**Figure 8: Normalized on Resistance vs. Junction Temperature**



**Figure 9: Maximum Safe Operating Area vs. Case Temperature**

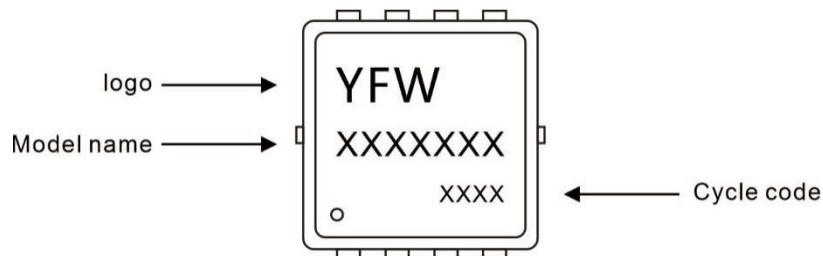


**Figure 10: Maximum Continuous Drain Current vs. Case Temperature**



**Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case**

### Marking Diagram



### Ordering information

Model name	Package	Unit Weight	Base Quantity	Packing Quantity
YFW50N04DF	PDFN3*3-8L	0.0023oz(0.065g)	5000pcs/reel	10000pcs/box 50000pcs/Carton

### Package Dimensions

#### PDFN3\*3-8L

Dim	Millimeter		mil	
	Min.	Max.	Min.	Max.
A	0.70	0.85	0.0276	0.0335
A1	-	0.05	-	0.002
b	0.20	0.40	0.008	0.016
c	0.10	0.25	0.004	0.010
D	3.15	3.45	0.124	0.136
D1	3.00	3.25	0.118	0.128
D2	2.29	2.65	0.09	0.104
E	3.15	3.45	0.124	0.136
E1	2.90	3.20	0.114	0.126
E2	1.54	1.94	0.061	0.076
E3	0.28	0.65	0.011	0.026
E4	0.37	0.77	0.015	0.030
E5	0.10	0.30	0.004	0.012
e	0.60	0.70	0.024	0.028
K	0.59	0.89	0.023	0.035
L	0.30	0.50	0.012	0.020
L1	0.06	0.20	0.002	0.008
t	-	0.13	-	0.005
Φ	10°C	14°C	10°C	14°C

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